


Search Notes 	Application/Control No. 10530310	Applicant(s)/Patent Under Reexamination CHAN ET AL.
	Examiner JASON K NIESZ	Art Unit 3751

SEARCHED			
Class	Subclass	Date	Examiner
141	21, 65	08/04/2009	JN
141	83, 94, 95	08/05/2009	JN
141	98, 192, 197, 234, 236, 248, 382	08/06/2009	JN
222	3, 174	08/06/2009	JN
248	636, 638	08/06/2009	JN

SEARCH NOTES		
Search Notes	Date	Examiner
consulted Tim Maust	08/04/2009	JN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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